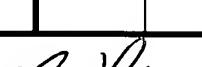


<b>Issue Classification</b> 	<b>Application/Control No.</b> 10/522,772	<b>Applicant(s)/Patent under Reexamination</b> FUNAHATA ET AL.
	<b>Examiner</b> David Y. Chung	<b>Art Unit</b> 2871

ORIGINAL		INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS		CLAIMED			NON-CLAIMED		
349		114		G	0	2	F	1/1335	/
CROSS REFERENCES							/		/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						/		/
349	113						/		/
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 5/29/07 (Assistant Examiner) (Date)				 David Neims Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date)			Total Claims Allowed: 10		
 6-4-07 (Legal Instruments Examiner) (Date)							O.G. Print Claim(s)		O.G. Print Fig.
							1		2

Claims renumbered in the same order as presented by applicant

**Total Claims Allowed: 10**

O.G.  
Print Claim(s)

O.G.  
Print Fig.